

MRT Technology (Taiwan) Co., Ltd Phone: +886-3-3288388 Web: www.mrt-cert.com Report No.: 2112TW0008-U2Report Version:V1.0Issue Date:2022-03-15

# **MEASUREMENT REPORT**

# FCC PART 15.407 WLAN 802.11a/n/ac/ax

- FCC ID: 2AXJ4EAP650
- APPLICANT: TP-Link Corporation Limited
- Application Type: Certification

Product: AX3000 Ceiling Mount Wi-Fi 6 Access Point

Model No.: EAP650

Brand Name: tp-link

FCC Classification: Unlicensed National Information Infrastructure (NII)

FCC Rule Part(s): Part15 Subpart E (Section 15.407)

Receive Date: December 26, 2021

**Test Date:** December 29, 2021 ~ March 01, 2022

Tested By	:	kevin ker	and a state of the	
Reviewed By	:	(Kevin Ker) Paddy Chen	lac-MRA	(TAF)
Approved By	:	(Paddy Chen) Amg ker	- And	Testing Laboratory 3261
•		(Chenz Ker)	_	

The test results relate only to the samples tested.

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in KDB 789033 D02v02r01. Test results reported herein relate only to the item(s) tested.

The test report shall not be reproduced except in full without the written approval of MRT Technology (Taiwan) Co., Ltd.



# **Revision History**

Report No.	Version	Description	Issue Date	Note	
2112TW0008-U2	V1.0	Initial Report	2022-03-15	Valid	

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# **General Information**

Applicant	TP-Link Corporation Limited			
Applicant Address	Room 901, 9/F., New East Ocean Centre, 9 Science Museum Road, Tsim Sha Tsui, Kowloon, Hongkong			
Manufacturer TP-Link Corporation Limited				
Manufacturer Address	Room 901, 9/F., New East Ocean Centre, 9 Science Museum Road, Tsim Sha Tsui, Kowloon, Hongkong			
Test Site	MRT Technology (Taiwan) Co., Ltd			
Test Site Address	No. 38, Fuxing Second Rd., Guishan Dist., Taoyuan City 333, Taiwan (R.O.C)			
MRT FCC Registration No.	291082			
FCC Rule Part(s)	Part 15.407			

## Test Facility / Accreditations

- 1. MRT facility is a FCC registered (Reg. No. 291082) test facility with the site description report on file and is designated by the FCC as an Accredited Test Firm.
- 2. MRT facility is an IC registered (MRT Reg. No. 21723) test laboratory with the site description on file at Industry Canada.
- MRT Lab is accredited to ISO 17025 by the Taiwan Accreditation Foundation (TAF Cert. No. 3261) in EMC, Telecommunications and Radio testing for FCC (Designation Number: TW3261), Industry Taiwan, EU and TELEC Rules.



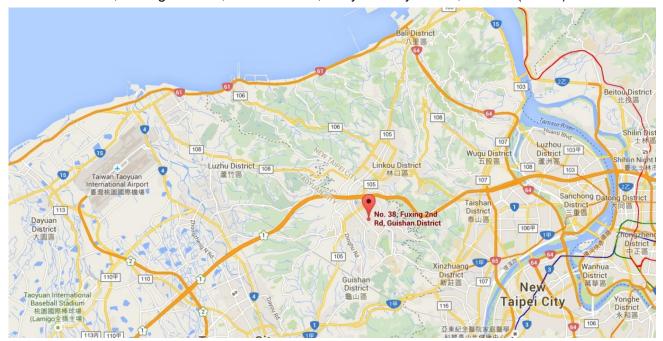
# 1. INTRODUCTION

## 1.1. Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Innovation, Science and Economic Development Canada and Certification and Engineering Bureau.

## 1.2. MRT Test Location

The map below shows the location of the MRT LABORATORY, its proximity to the Taoyuan City. These measurement tests were conducted at the MRT Technology (Taiwan) Co., Ltd. Facility located at No.38, Fuxing 2nd Rd., Guishan Dist., Taoyuan City 33377, Taiwan (R.O.C).





# 2. PRODUCT INFORMATION

## 2.1. Equipment Description

Product Name:	AX3000 Ceiling Mount Wi-Fi 6 Access Point		
Model No.:	EAP650		
Brand Name:	tp-link		
Wi-Fi Specification:	802.11a/b/g/n/ac/ax		
EUT Identification No.:	20211225Sample#11 (Conducted)		
EUT Identification No	20211225Sample#10 (Radiated and AC conducted Emission)		
Power Type:	By AC-DC Adapter or 802.11at PoE		
Accessory			
	Model: T120150-2B1		
Adapter:	INPYUT: 100-240~50/60Hz 0.6A		
	OUTPUT: DC12.0V, 1.5A		

Note: The information shown above was provided by manufacturer, and the accuracy of the information shall be the responsibility of the manufacturer.

# 2.2. Product Specification Subjective to this Report

	For 902 44 c/m LIT20/co \/LIT20/cy LIF20;
Frequency Range	For 802.11a/n-HT20/ac-VHT20/ax-HE20:
	5180~5240MHz, 5260~5320MHz, 5500~5700MHz, 5745~5825MHz
	For 802.11n-HT40/ac-VHT40/ax-HE40:
	5190~5230MHz, 5270~5310MHz, 5510~5670MHz, 5755~5795MHz
	For 802.11ac-VHT80/ax-HE80:
	5210MHz, 5290MHz, 5530MHz, 5610 MHz ,5775MHz
	For 802.11ac-VHT160/ax-HE160:
	5250MHz, 5570MHz
Type of Modulation	802.11a/n/ac: OFDM
	802.11ax: OFDMA
Data Rate	802.11a: 6/9/12/18/24/36/48/54Mbps
	802.11n: up to 300Mbps
	802.11ac: up to 1732Mbps
	802.11ax: up to 2402Mbps

Note: For other features of this EUT, test report will be issued separately.



# 2.3. Working Frequencies for this report

## 802.11a/n-HT20/ac-VHT20/ax-HE20

Channel	Frequency	Channel	Frequency	Channel	Frequency
36	5180 MHz	40	5200 MHz	44	5220 MHz
48	5240 MHz	52	5260 MHz	56	5280 MHz
60	5300 MHz	64	5320 MHz	100	5500 MHz
104	5520 MHz	108	5540 MHz	112	5560 MHz
116	5580 MHz	120	5600 MHz	124	5620 MHz
128	5640 MHz	132	5660 MHz	136	5680 MHz
140	5700 MHz	149	5745 MHz	153	5765 MHz
157	5785 MHz	161	5805 MHz	165	5825 MHz

#### 802.11n-HT40/ac-VHT40/ax-HE40

Channel	Frequency	Channel	Frequency	Channel	Frequency
38	5190 MHz	46	5230 MHz	54	5270 MHz
62	5310 MHz	102	5510 MHz	110	5550MHz
118	5590 MHz	126	5630 MHz	134	5670 MHz
151	5755 MHz	159	5795 MHz		

#### 802.11ac-VHT80/ax-HE80

Channel	Frequency	Channel	Frequency	Channel	Frequency
42	5210 MHz	58	5290 MHz	106	5530 MHz
122	5610 MHz	155	5775 MHz		

## 802.11ac-VHT160/ax-HE160

Channel	Frequency	Channel	Frequency	Channel	Frequency
50	5250MHz	114	5570 MHz		



Antenna Type	Frequency Band (MHz)	T <sub>X</sub> Paths	Max Antenna Gain (dBi)	Beamforming Directional	CDD Directional Gain (dBi)	
				Gain (dBi)	For Power	For PSD
	2412 ~ 2462	2	3.80	6.81	3.80	6.81
	5150 ~ 5250	2	5.00	8.01	5.00	8.01
Omni-Directional	5250 ~ 5350	2	5.00	8.01	5.00	8.01
	5470 ~ 5725	2	5.00	8.01	5.00	8.01
	5725 ~ 5850	2	5.00	8.01	5.00	8.01

#### 2.4. Description of Available Antennas

Note:

1. The EUT supports Cyclic Delay Diversity (CDD) mode, and CDD signals are correlated.

If all antennas have the same gain,  $G_{ANT}$ , Directional gain =  $G_{ANT}$  + Array Gain, where Array Gain is as follows.

• For power spectral density (PSD) measurements on all devices,

Array Gain = 10 log ( $N_{ANT}/N_{SS}$ ) dB;

• For power measurements on IEEE 802.11 devices,

Array Gain = 0 dB for  $N_{ANT} \le 4$ ;

- 2. The EUT also supports Beam Forming mode, and the Beam Forming support 802.11ac/ax, not include 802.11a/b/g/n. BF Directional gain =  $G_{ANT}$  + 10 log (N<sub>ANT</sub>).
- 3. All information declared by manufacturer.



## 2.5. Test Mode

Test Mode	Mode 1: Transmit by 802.11a (6Mbps) (CDD mode)
	Mode 2: Transmit by 802.11ac-VHT20 (MCS0) (CDD mode)
	Mode 3: Transmit by 802.11ac-VHT40 (MCS0) (CDD mode)
	Mode 4: Transmit by 802.11ac-VHT80 (MCS0) (CDD mode)
	Mode 5: Transmit by 802.11ac-VHT160 (MCS0) (CDD mode)
	Mode 6: Transmit by 802.11ax-HE20 (MCS0) (CDD mode)
	Mode 7: Transmit by 802.11ax-HE40 (MCS0) (CDD mode)
	Mode 8: Transmit by 802.11ax-HE80 (MCS0) (CDD mode)
	Mode 9: Transmit by 802.11ax-HE160 (MCS0) (CDD mode)
	Mode 10: Transmit by 802.11ac-VHT20 (MCS0) (Beam-Forming mode)
	Mode 11: Transmit by 802.11ac-VHT40 (MCS0) (Beam-Forming mode)
	Mode 12: Transmit by 802.11ac-VHT80 (MCS0) (Beam-Forming mode)
	Mode 13: Transmit by 802.11ac-VHT160 (MCS0) (Beam-Forming mode)
	Mode 14: Transmit by 802.11ax-HE20 (MCS0) (Beam-Forming mode)
	Mode 15: Transmit by 802.11ax-HE40 (MCS0) (Beam-Forming mode)
	Mode 16: Transmit by 802.11ax-HE80 (MCS0) (Beam-Forming mode)
	Mode 17: Transmit by 802.11ax-HE160 (MCS0) (Beam-Forming mode)

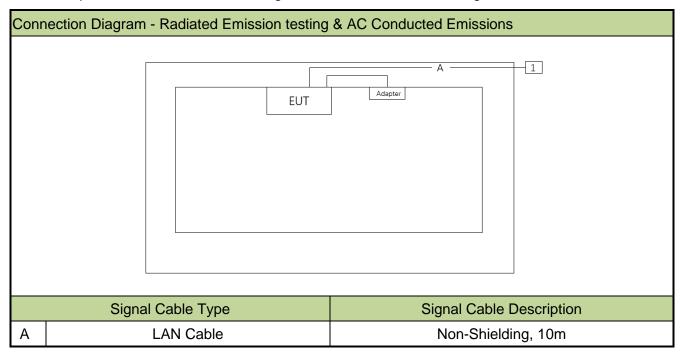
Note 1: Due to the same modulation between 802.11n and 802.11ac, so 802.11n-HT20 and HT40 are covered by 802.11ac-VHT20 and VHT40 in this report, meanwhile, power setting for 802.11n-HT20 and HT40 will not be greater than 802.11ac-VHT20 and VHT40.

Note 2: Due to CDD mode was the worst mode, so all test items were evaluated in this report. The beamforming mode only evaluated the RF output power.



## 2.6. Configuration of Test System

The devicewas tested per the guidance ANSI C63.10: 2013 was used to reference the appropriate EUT setup for radiated emissions testing and AC line conducted testing.



## 2.7. Test System Details

The types for all equipments, plus descriptions of all cables used in the tested system (including inserted cards) are:

Pro	odu	ıct	Manufacturer	Model No.	Serial No.	Power Cord
1		Notebook	Lenovo	E431	PF-10ZRN 13/12	Non-Shielded, 1.8m

#### 2.8. Description of Test Software

The test utility software used during testing was "QSPR", the version is V5.0-00196. Note: Final power setting please refer to operational description.

#### 2.9. Applied Standards

According to the specifications of the manufacturer, the EUT must comply with the requirements of the following standards:

- FCC Part 15.407
- KDB 789033 D02v02r01
- KDB 662911 D01v02r01
- ANSI C63.10-2013

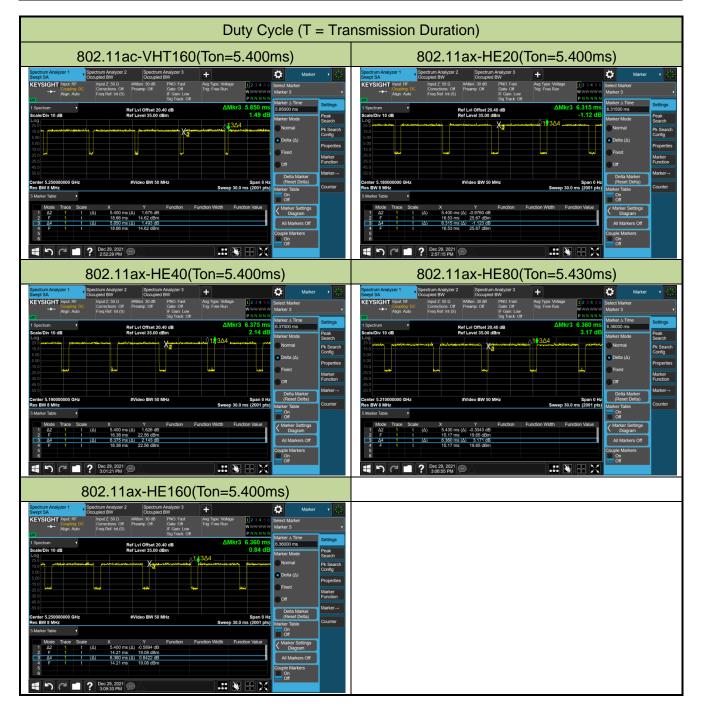


# 2.10. Duty Cycle

The maximum achievable duty cycles for all modes were determined based on measurements performed on a spectrum analyzer in zero-span mode with RBW = 8MHz, VBW = 50MHz. The RBW and VBW were both greater than 50/T, where T is the minimum transmission duration, and the number of sweep points across T was greater than 100. The duty cycles are as follows:

Test Mode	Duty Cycle		
802.11a	96.81%		
802.11ac-VHT20	85.99%		
802.11ac-VHT40	84.04%		
802.11ac-VHT80	84.60%		
802.11ac-VHT160	92.31%		
802.11ax-HE20	85.51%		
802.11ax-HE40	84.71%		
802.11ax-HE80	85.38%		
802.11ax-HE160	84.91%		
Duty Cycle (Ton = Tr	ansmission Duration)		
802.11a (Ton=1.975ms)	802.11ac-VHT20(Ton=5.430ms)		
Bigendian Analyzer 1   Opcoderin Analyzer 2   Opcoderin Analyzer 3   Image: Analyzer 3	Spectrum Analyzer 1   Operation Analyzer 2   Spectrum Analyzer 3   Image: Conserved SW		
Boc2.11acc-VHT40(Ton=5.370mb)	BO22.11ac-VHT80(Ton=5.355ms)     Spectrum Analyzer 2 Occupied DW     Occupied DW     Cocupied DW     Network of the text of the tex		





# 2.11. Test Configuration

The devicewas tested per the guidance of KDB 789033 D02v02r01. ANSI C63.10-2013 was used to reference the appropriate EUT setup for radiated spurious emissions testingand AC line conducted testing.

## 2.12. EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and/or no modifications were made during testing.



## 2.13. Labeling Requirements

#### Per 2.1074 & 15.19; Docket 95-19

The label shall be permanently affixed at a conspicuous location on the device; instruction manual or pamphletsupplied to the user and be readily visible to the purchaser at the time of purchase. However, when the device so small wherein placement of the label with specified statement is not practical, only the FCC ID must be displayed on the device per Section 15.19(a)(5). Please see attachment for FCC ID label and label location.



# 3. DESCRIPTION OF TEST

#### 3.1. Evaluation Procedure

The measurement procedures described in the American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices (ANSI C63.10-2013), and the guidance provided in KDB 789033 D02v02r01 were used in themeasurement.

## 3.2. AC Line Conducted Emissions

The line-conducted facility is located inside an8'x4'x4' shielded enclosure. A 1m x 2m wooden table 80cm high is placed 40cm away from the vertical wall and 80cm away from the sidewall of the shielded room. Two 10kHz-30MHz,  $50\Omega/50$ uH Line-Impedance Stabilization Networks (LISNs) are bonded to the shielded room floor. Power to the LISNs is filtered by external high-current high-insertion loss power line filters. These filters attenuate ambient signal noise from entering the measurement lines. These filters are also bonded to the shielded enclosure.

The EUT is powered from one LISN and the support equipment is powered from the second LISN. All interconnecting cables more than 1 meter were shortened to a 1 meter length by non-inductive bundling (serpentine fashion) and draped over the back edge of the test table. All cables were at least 40cm above the horizontal reference ground-plane. Power cables for support equipment were routed down to the second LISN while ensuring that that cables were not draped over the second LISN.

Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The RF output of the LISN was connected to the receiver and exploratory measurements were made to determine the frequencies producing the maximum emission from the EUT. The receiver was scanned from 150kHz to 30MHz. The detector function was set to peak mode for exploratory measurements while the bandwidth of the analyzer was set to 9kHz. The EUT, support equipment, and interconnecting cables were arranged and manipulated to maximize each emission. Each emission was also maximized by varying: power lines, the mode of operation or data exchange speed, or support equipment whichever determined the worst-case emission. Once the worst case emissions have been identified, the one EUT cable configuration/arrangement and mode of operation that produced these emissions are used for final measurements on the same test site. The analyzer is set to CISPR quasi-peak and average detectors with a 9kHz resolution bandwidth for final measurements.

An extension cord was used to connect to a single LISN which powered by EUT. The extension cord was calibrated with LISN, the impedance and insertion loss are compliance with the requirements as stated in ANSI C63.10-2013.



#### 3.3. Radiated Emissions

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. For measurements above 1GHz absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections. For measurements below 1GHz, the absorbers are removed. A MF Model 210SS turntable is used for radiated measurement. It is a continuously rotatable, remote controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An80cm high PVC support structure is placed on top of the turntable. For all measurements, the spectrum was scanned through all EUT azimuths and from 1 to 4 meter receive antenna height using a broadband antenna from 30MHz up to the upper frequency shown in 15.33(b)(1) depending on the highest frequency generated or used in the device or on which the device operates or tunes. For frequencies above 1GHz, linearly polarized double ridge horn antennas were used. For frequencies below 30MHz, a calibrated loop antenna was used. When exploratory measurements were necessary, they were performed at 1 meter test distance inside the semi-anechoic chamber using broadband antennas, broadband amplifiers, and spectrum analyzers to determine the frequencies and modes producing the maximum emissions. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. The test set-up for frequencies below 1GHz was placed on top of the 0.8 meter high, 1 x 1.5 meter table; and test set-up for frequencies 1-40GHz was placed on top of the 1.5 meter high, 1 x 1.5 meter table. The EUT, support equipment, and interconnecting cables were arranged and manipulated tomaximize each emission. Appropriate precaution was taken to ensure that all emissions from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, if applicable, turntable azimuth, and receive antenna height was noted for each frequency found.

Final measurements were made in the semi-anechoic chamber using calibrated, linearly polarized broadband and horn antennas. The test setup was configured to the setup that produced the worst case emissions. The spectrum analyzer was set to investigate all frequencies required for testing to compare the highest radiated disturbances with respect to the specified limits. The turntable containing the EUT was rotated through 360 degrees and the height of the receive antenna was varied 1 to 4 meters and stopped at the azimuth and height producing the maximum emission. Each emission was maximized by changing the orientation of the EUT through three orthogonal planes and changing the polarity of the receive antenna, whichever produced the worst-case emissions. According to 3dB Beam-Width of horn antenna, the horn antenna should be always directed to the EUT when rising height.



# 4. ANTENNA REQUIREMENTS

#### Excerpt from §15.203 of the FCC Rules/Regulations:

"An intentional radiator antenna shall be designed to ensure that no antenna other than that furnished by the responsible party can be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section."

- The antenna of the device is **permanently attached**.
- There are no provisions for connection to an external antenna.

#### **Conclusion:**

The unit complies with the requirement of §15.203.



# 5. TEST EQUIPMENT CALIBRATION DATE

Conducted Emissions -SR2

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
Two-Line V-Network	R&S	ENV 216	MRTTWA00019	1 year	2022/3/23
Two-Line V-Network	R&S	ENV 216	MRTTWA00020	1 year	2022/4/24
8-Wire ISN (T8)	R&S	ENY81	MRTTWA00018	1 year	2022/5/30
EMI Test Receiver	R&S	ESR3	MRTTWA00045	1 year	2022/5/25
Temperature/Humidity Meter	TFA	35.1083	MRTTWA00050	1 year	2022/6/3

#### Radiated Emissions – AC1/AC2

Instrument	Manufacturer	Туре No.	Asset No.	Cali. Interval	Cali. Due Date
Active Loop Antenna	SCHWARZBECK	FMZB 1519B	MRTTWA00002	1 year	2022/4/27
Broadband TRILOG Antenna	SCHWARZBECK	VULB 9162	MRTTWA00001	1 year	2022/10/4
Broadband Horn Antenna	SCHWARZBECK	BBHA 9120D	MRTTWA00003	1 year	2022/4/24
Broadband Horn Antenna	RFSPIN	DRH18-E	MRTTWA00087	1 year	2022/6/28
Broadband Horn Antenna	SCHWARZBECK	BBHA 9170	MRTTWA00004	1 year	2022/4/24
Broadband Preamplifier	SCHWARZBECK	BBV 9718	MRTTWA00005	1 year	2022/4/24
Broadband Preamplifier	EMC Instruments corporation	EMC118A45S E	MRTTWA00088	1 year	2022/6/28
Broadband Amplifier	SCHWARZBECK	BBV 9721	MRTTWA00006	1 year	2022/4/24
Signal Analyzer	R&S	FSV40	MRTTWA00007	1 year	2022/3/23
EMI Test Receiver	R&S	ESR3	MRTTWA00009	1 year	2022/3/24
EXA Signal Analyzer	KEYSIGHT	N9010A	MRTTWA00012	1 year	2022/11/14
Antenna Cable	HUBERSUHNER	SF106	MRTTWE00010	1 year	2022/6/28
Cable	Rosnol	K1K50-UP026 4-K1K50-4M	MRTTWE00012	1 year	2022/6/20
Antenna Cable	HUBERSUHNER	SF106	MRTTWE00034	1 year	2022/6/28
Cable	HUBERSUHNER	EMC105-NM- NM-3000	MRTTWE00035	1 year	2022/6/28
Temperature/Humidity Meter	TFA	35.1078.10.IT	MRTTWA00032	1 year	2022/6/6



#### Conducted Test Equipment

Instrument	Manufacturer	Type No.	Asset No.	Cali. Interval	Cali. Due Date
X-Series USB Peak and	KEYSIGHT	U2021XA		1	2022/4/21
Average Power Sensor	KE I SIGHT	020217A	MRTTWA00014	1 year	2022/4/21
EXA Signal Analyzer	KEYSIGHT	N9010A	MRTTWA00012	1 year	2022/11/14
EXA Signal Analyzer	KEYSIGHT	N9010B	MRTTWA00074	1 year	2022/7/19
Attenuator	WTI	218FS-20	MRTTWE00027	1 year	2022/6/16
Attenuator	WTI	218FS-10	MRTTWE00028	1 year	2022/6/16
Attenuator	WTI	218FS-06	MRTTWE00029	1 year	2022/6/16
Temperature/Humidity Meter	TFA	35.1083	MRTTWA00050	1 year	2022/6/3

Software	Version	Function
v3	9.160520a	EMI Test Software



# 6. MEASUREMENT UNCERTAINTY

Where relevant, the following test uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k = 2.

AC Conducted Emission Measurement
Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)):
0.15MHz~30MHz: ± 2.53dB
Radiated Spurious Emission
Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)):
9kHz~30MHz: ± 3.92dB
30MHz~1GHz: ± 4.25dB
1GHz~18GHz: ± 4.40dB
18GHz~40GHz: ± 4.45dB
Conducted Power (Carrier Power / Power Density)
Measuring Uncertainty for a Level of Confidence of 95% $(U=2Uc(y))$ : ± 0.84dB
Conducted Spurious Emission
Measuring Uncertainty for a Level of Confidence of 95% $(U=2Uc(y))$ : ± 2.65 dB
Occupied Bandwidth
Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)): 3.3%
Temp. / Humidity
Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)): ±0.82°C/ ±3%
Frequency Error
Measuring Uncertainty for a Level of Confidence of 95% (U=2Uc(y)): ±78.4Hz



# 7. TEST RESULT

#### 7.1. Summary

FCC	Test Description	Test Limit	Test	Test	Reference
Section(s)			Condition	Result	
15.407(a)	26dB Bandwidth	N/A		Pass	Section 7.2
15.407(e)	6dB Bandwidth	≥ 500kHz		Pass	Section 7.3
15.407(a)(1)(ii),	Maximum Conducted	Refer to section 7.4		Pass	Section 7.4
(2), (3)(i)	Output Power	Refer to section 7.4	Conductod	Pass	Section 7.4
15.407(h)(1)	Transmit Power Control	≤ 24 dBm	Conducted	Pass	Section 7.5
15.407(a)(1)(ii),	Peak Power Spectral	Defer to continue 7.0		Pass	Continue 7.0
(2), (3), (12)	Density	Refer to section 7.6		F 855	Section 7.6
15.407(g)	Frequency Stability	N/A		Pass	Section 7.7
15.407(b)(1),	Undesirable Emissions	Refer to Section 7.8		Pass	
(2), (3), (4)(i)	Undesirable Emissions	Refer to Section 7.6		Pass	
15 205 15 200	General Field Strength	Emissions in	Radiated		Section
15.205, 15.209	Limits (Restricted Bands	restrictedbands must	Raulaleu	Pass	7.8 & 7.9
15.407(b)(8),	andRadiated Emission	meet theradiated limits		Pass	
(9), (10)	Limits)	detailed in15.209			
	AC Conducted		Line		Section
15.207	Emissions	< FCC 15.207 limits		Pass	
	150kHz - 30MHz		Conducted		7.10

Notes:

- The analyzer plots shown in this section were all taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables and attenuators used as part of the system to connect the EUT to the analyzer at all frequencies of interest.
- 2) Output power test was verified over all data rates of each mode (data refers to operational description), and then choose the maximum power output (low data rate) for final test of each channel.
- 3) For radiated emission test, every axis (X, Y, Z) was also verified. The test results shown in the following sections represent the worst-case emissions.
- 4) Determining compliance is based on the test results met the regulation limits or requirements declared by clients, and the test results don't take into account the value of measurement uncertainty.
- 5) EUT supports one configuration only in 802.11ax full RU mode.



## 7.2. 26dB & 99% Bandwidth Measurement

#### 7.2.1.Test Limit

N/A

#### 7.2.2.Test Procedure used

KDB 789033 D02v02r01- Section C.1 (26dB Bandwidth)

KDB 789033 D02v02r01- Section D (99% Bandwidth)

#### 7.2.3.TestSetting

#### 26dB Bandwidth

- The analyzers' automatic bandwidth measurement capability was used to perform the 26dB bandwidth measurement. The "X" dB bandwidth parameter was set to X = 26. The automatic bandwidth measurement function also has the capability of simultaneously measuring the 99% occupied bandwidth. The bandwidth measurement was not influenced by any intermediated power nulls in the fundamental emission.
- 2. RBW = approximately 1% of the emission bandwidth.
- 3. VBW >RBW.
- 4. Detector = Peak.
- 5. Trace mode = max hold.

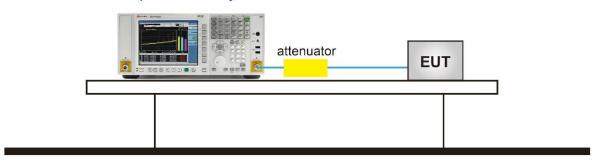
#### 99% Bandwidth

- 1. Set center frequency to the nominal EUT channel center frequency.
- 2. Set span = 1.5 times to 5.0 times the OBW.
- 3. Set RBW = 1% to 5% of the OBW
- 4. Set VBW ≥ 3×RBW
- 5. Detector = Peak.
- 6. Use the 99% power bandwidth function of the instrument.



# 7.2.4.Test Setup

Spectrum Analyzer





#### 7.2.5.Test Result

Product	AX3000 Ceiling Mount Wi-Fi 6 Access Point	Temperature	23°C ~ 28°C
Test Engineer	Eric Lin	Relative Humidity	54% ~ 57%
Test Site	SR2	Test Date	2022/02/09 ~ 2022/03/01

Test Mode	Data Rate/ MCS	Channel No.	Frequency (MHz)	26dB Bandwidth (MHz)	99% Bandwidth (MHz)
802.11a	6Mbps	36	5180	19.13	16.50
802.11a	6Mbps	44	5220	20.17	16.54
802.11a	6Mbps	48	5240	20.35	16.50
802.11a	6Mbps	52	5260	19.05	16.48
802.11a	6Mbps	60	5300	19.12	16.46
802.11a	6Mbps	64	5320	19.03	16.51
802.11a	6Mbps	100	5500	18.96	16.48
802.11a	6Mbps	116	5580	19.18	16.48
802.11a	6Mbps	140	5700	19.26	16.47
802.11a	6Mbps	149	5745	26.93	16.68
802.11a	6Mbps	157	5785	27.54	16.69
802.11a	6Mbps	165	5825	27.96	16.70
802.11ac-VHT20	MCS0	36	5180	20.34	17.72
802.11ac-VHT20	MCS0	44	5220	21.18	17.77
802.11ac-VHT20	MCS0	48	5240	21.93	17.76
802.11ac-VHT20	MCS0	52	5260	19.95	17.72
802.11ac-VHT20	MCS0	60	5300	20.58	17.71
802.11ac-VHT20	MCS0	64	5320	20.22	17.71
802.11ac-VHT20	MCS0	100	5500	20.31	17.73
802.11ac-VHT20	MCS0	116	5580	20.13	17.73
802.11ac-VHT20	MCS0	140	5700	20.98	17.76
802.11ac-VHT20	MCS0	149	5745	36.19	18.68
802.11ac-VHT20	MCS0	157	5785	36.97	18.62
802.11ac-VHT20	MCS0	165	5825	38.23	19.16



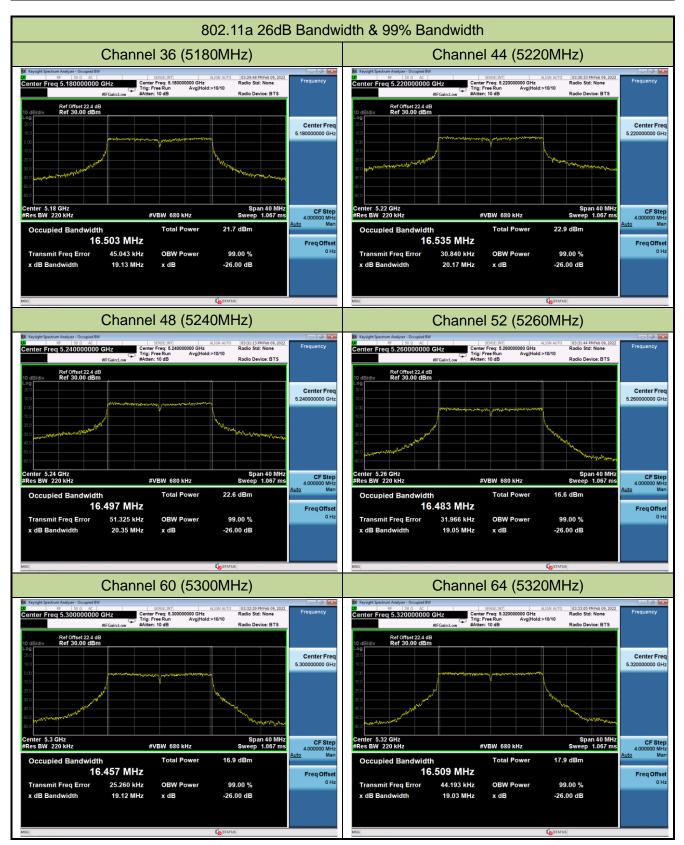
Test Mode	Data Rate/ MCS	Channel No.	Frequency (MHz)	26dB Bandwidth (MHz)	99% Bandwidth (MHz)
802.11ac-VHT40	MCS0	38	5190	39.87	36.04
802.11ac-VHT40	MCS0	46	5230	70.69	36.82
802.11ac-VHT40	MCS0	54	5270	39.60	35.94
802.11ac-VHT40	MCS0	62	5310	39.20	35.90
802.11ac-VHT40	MCS0	102	5510	39.46	35.93
802.11ac-VHT40	MCS0	110	5550	39.39	35.96
802.11ac-VHT40	MCS0	134	5670	39.75	36.01
802.11ac-VHT40	MCS0	151	5755	78.97	37.42
802.11ac-VHT40	MCS0	159	5795	74.50	37.04
802.11ac-VHT80	MCS0	42	5210	81.30	75.34
802.11ac-VHT80	MCS0	58	5290	80.78	75.29
802.11ac-VHT80	MCS0	106	5530	81.83	75.33
802.11ac-VHT80	MCS0	122	5610	81.74	75.37
802.11ac-VHT80	MCS0	155	5775	150.8	76.37
802.11ac-VHT160	MCS0	50	5250	163.1	154.24
802.11ac-VHT160	MCS0	114	5570	164.3	153.06
802.11ax-HE20	MCS0	36	5180	21.74	19.12
802.11ax-HE20	MCS0	44	5220	23.51	19.17
802.11ax-HE20	MCS0	48	5240	23.09	19.18
802.11ax-HE20	MCS0	52	5260	21.70	19.09
802.11ax-HE20	MCS0	60	5300	21.66	19.08
802.11ax-HE20	MCS0	64	5320	21.68	19.09
802.11ax-HE20	MCS0	100	5500	21.51	19.11
802.11ax-HE20	MCS0	116	5580	21.95	19.10
802.11ax-HE20	MCS0	140	5700	21.43	19.09
802.11ax-HE20	MCS0	149	5745	33.35	19.54
802.11ax-HE20	MCS0	157	5785	34.63	19.47
802.11ax-HE20	MCS0	165	5825	38.47	19.47



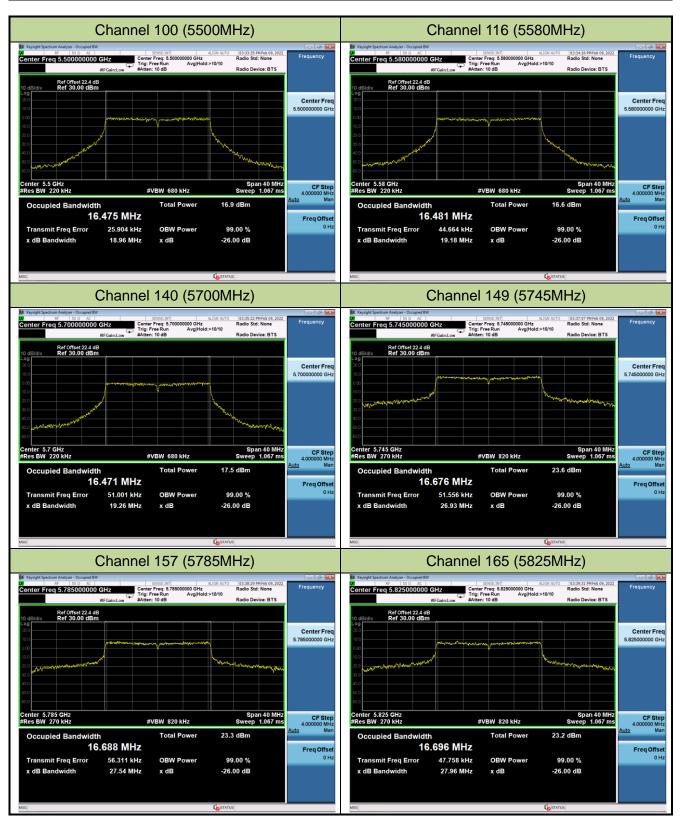
Test Mode	Data Rate/ MCS	Channel No.	Frequency (MHz)	26dB Bandwidth (MHz)	99% Bandwidth (MHz)
802.11ax-HE40	MCS0	38	5190	40.41	37.57
802.11ax-HE40	MCS0	46	5230	68.48	38.26
802.11ax-HE40	MCS0	54	5270	40.32	37.63
802.11ax-HE40	MCS0	62	5310	40.32	37.68
802.11ax-HE40	MCS0	102	5510	40.37	37.72
802.11ax-HE40	MCS0	110	5550	40.25	37.69
802.11ax-HE40	MCS0	134	5670	40.26	37.72
802.11ax-HE40	MCS0	151	5755	72.19	38.36
802.11ax-HE40	MCS0	159	5795	71.95	38.30
802.11ax-HE80	MCS0	42	5210	81.74	77.18
802.11ax-HE80	MCS0	58	5290	81.42	77.14
802.11ax-HE80	MCS0	106	5530	81.65	77.08
802.11ax-HE80	MCS0	122	5610	82.24	77.17
802.11ax-HE80	MCS0	155	5775	144.8	78.53
802.11ax-HE160	MCS0	50	5250	162.9	154.33
802.11ax-HE160	MCS0	114	5570	161.8	154.59

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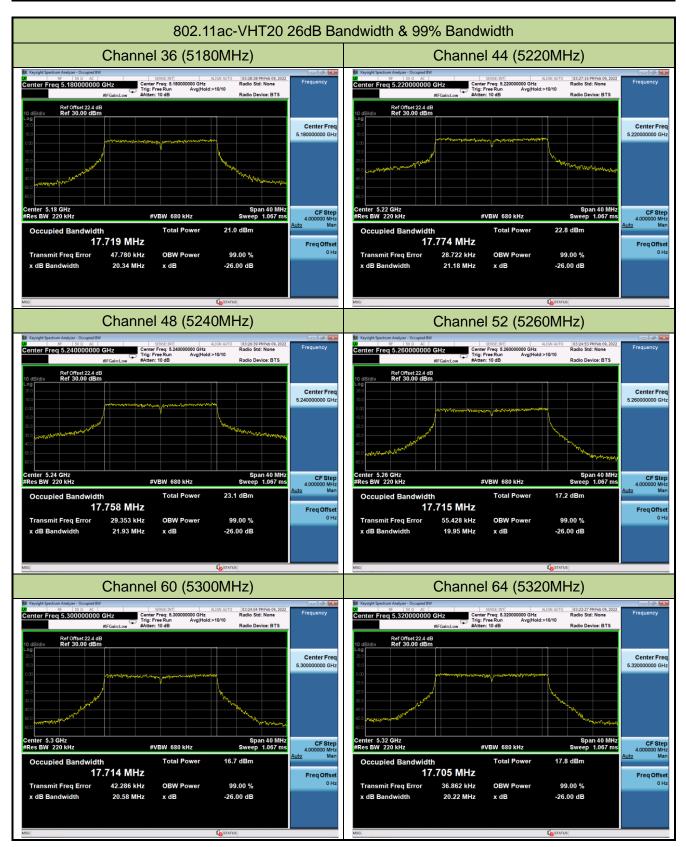




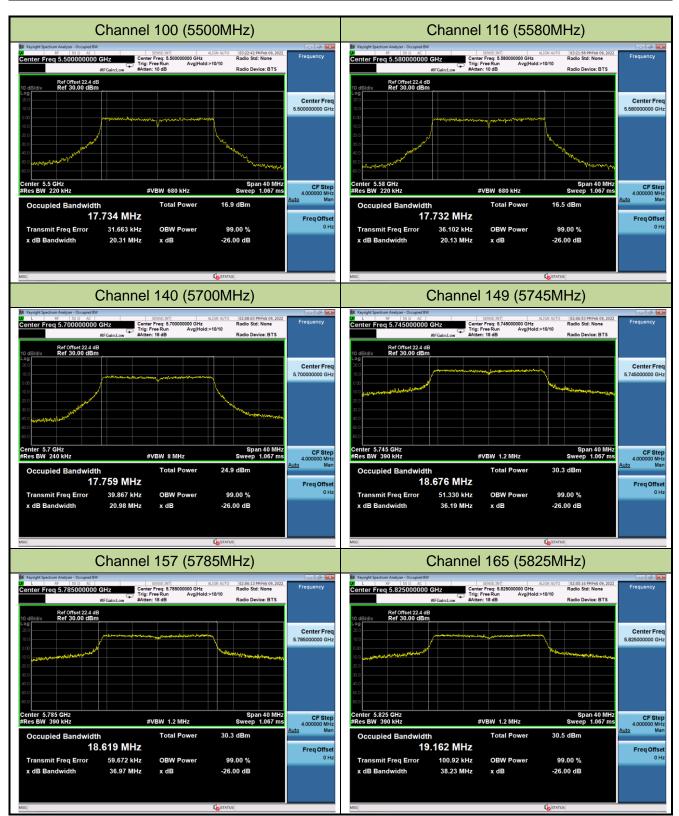




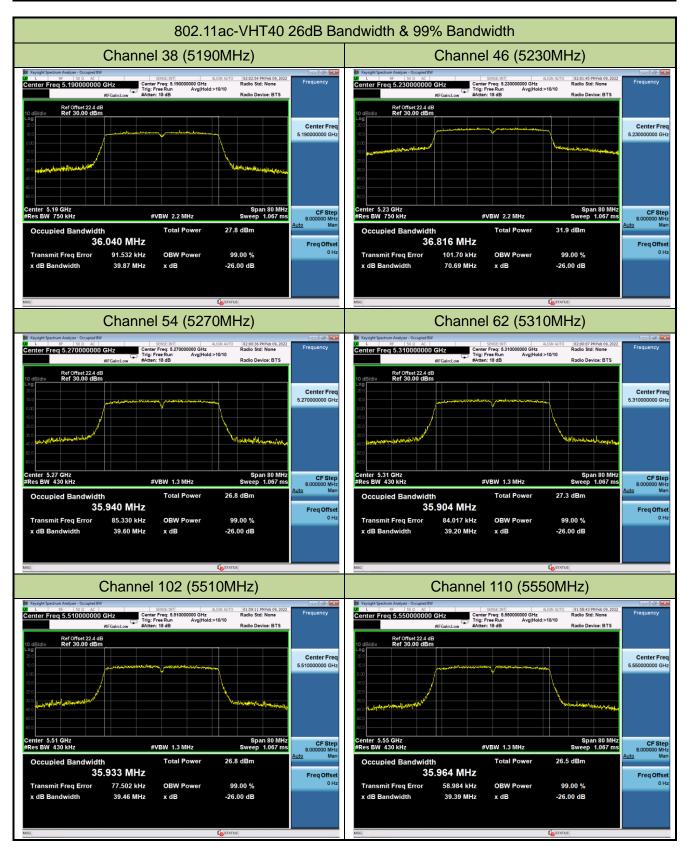








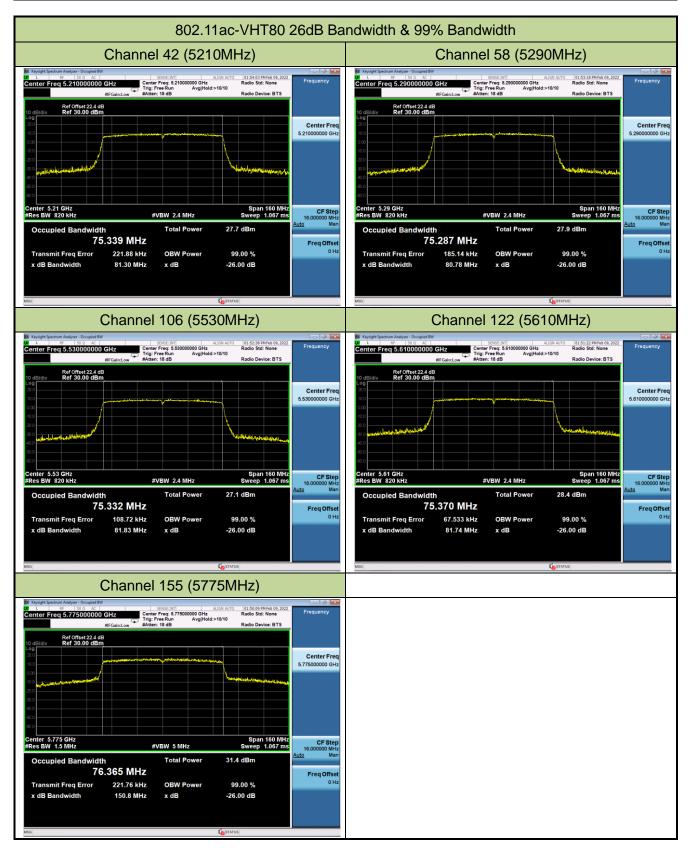






Channel 134 (5670MHz)	Channel 151 (5755MHz)		
If Knjight Spectrum Ankjøzer - Occupied BW     Stroke INT     ALION AUTO     01:57:49 PM (reb 05, 2022)     Context Frag. 56,70000000 GHz     Radio Std: None       Center Frag. 5.670000000 GHz     Gradin Std: None     ALION AUTO     01:57:49 PM (reb 05, 2022)     Fraguency       If Grain.Cov     ALION AUTO     01:57:49 PM (reb 05, 2022)     Context Frag. 56, 70000000 GHz     Radio Std: None       ALION AUTO     Stroke INT     ALION AUTO     01:57:49 PM (reb 05, 2022)     Fraguency	If Kryight Spectrum Awayser - Occupied BW     Strict_INT     A.Joh A/TO     01.5617 PH/Fe0 05,2022       Center Freq 5.7550000000 GHz     Center Freq 5.755000000 GHz     Radio Std: None     Frequency       #EfGaint.cov     Freq Strict_Freq 05,755000000 GHz     Radio Std: None     Frequency		
Ref Offset 22.4 dB 10 dB/div Ref 30.00 dBm	Ref Offset 22.4 dB 10 dB/div Ref 30.00 dBm		
Leg 200 100 100 100 100 100 100 100	Log 200 100 100 100 100 100 100 100		
Center 5.67 GHz Span 80 MHz CF Step #Res BW 430 KHz #VBW 1.3 MHz Sweep 1.067 ms 800000 MHz	Center 5.755 GHz Span 80 MHz CF Step #Res BW 820 kHz #VBW 2.4 MHz Sweep 1.067 ms 800000 MHz		
Occupied Bandwidth Total Power 27.4 dBm Auto Man   36.010 MHz Transmit Freq Error 57.841 kHz OBW Power 99.00 % 0 Hz   x dB Bandwidth 39.75 MHz x dB -26.00 dB 0 Hz	Occupied Bandwidth     Total Power     31.3 dBm     Auto     Man       37.417 MHz     Transmit Freq Error     178.72 kHz     OBW Power     99.00 %     Preq Offset     0 Hz       x dB Bandwidth     78.97 MHz     x dB     -26.00 dB     Preq Offset     0 Hz		
MISG     Channel 159 (5795MHz)       Image: State Stat			
BFGaint.cov   Trig: Free Run   Avg/Hold:>10/10   Radio Device: BTS     0   BFGaint.cov   BAtter: 16 B   Arg/Hold:>10/10   Radio Device: BTS     0   BFGaint.cov   BAtter: 16 B   B   Center Freq     0   BFGaint.cov   B   Center Freq   5.79500000 GHz     00   BFGaint.cov   B   B   Center Freq     00   B   B   B   B     00   B   B   B   B   B   B <td></td>			
Occupied Bandwidth Total Power 30.9 dBm 37.044 MHz Transmit Freq Error 108.10 kHz OBW Power 99.00 % x dB Bandwidth 74.50 MHz x dB -26.00 dB			







802.11	ac-VHT160 26dB B	andwidth & 99% Bandwidth			
Channel 50 (5250	)MHz)	Channel 114 (5570MHz)			
Keyseyki Spectrum Analyzer Occupied BW Server Hitti Keyseyki Spectrum Analyzer Occupied BW Key	IGN AUTO 01:48:08 PM Feb 09, 2022 Radio Std: None Radio Device: BTS	Knowled Spectrum Analyses - Occupied BW Je L Strate State			
Ref Offset 22.4 dB 10 dB/div Ref 30.00 dBm		Ref Offset 22.4 dB 10 dB/div Ref 30.00 dBm			
	Center Freq 5.25000000 GHz	200 200 100 0.0			
	A Construction of the Construction				
800 Center 5.25 CHz #Res BW 1.8 MHz #VBW 5 MHz	Span 320 MHz CF Step Sweep 1.067 ms 32.00000 MHz	00     0			
Occupied Bandwidth Total Power 153.24 MHz	29.4 dBm	Occupied Bandwidth Total Power 29.2 dBm 153.06 MHz Freq Offse			
Transmit Freq Error 648.33 kHz OBW Power	99.00 %	Transmit Freq Error -22.207 kHz OBW Power 99.00 %			
x dB Bandwidth 163.1 MHz x dB	-26.00 dB	x dB Bandwidth 164.3 MHz x dB -26.00 dB			



